Notice of References Cited Application/Control No. 10/565,676 Examiner Keath T. Chen Applicant(s)/Patent Under Reexamination IIZUKA, HACHISHIRO Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,596,085 🗆 🗆	07-2003	Schmitt et al.	118/726
*	В	US-6,517,634 🗆 🗆	02-2003	Pang et al.	118/715
*	С	US-6,409,839 □□	06-2002	Sun et al.	118/726
*	D	US-6,470,144 🗆 🗆	10-2002	Tarutani et al.	392/396
*	E	US-5,776,254 🗆 🗆	07-1998	Yuuki et al.	118/725
*	F	US-4,188,368 □□	02-1980	Frosch et al.	423/350
*	G	US-6,074,487 🗆 🗆	06-2000	Yoshioka et al.	118/726
*	Н	US-6,036,783	03-2000	Fukunaga et al.	118/724
*	1	US-6,302,965 □□	10-2001	Umotoy et al.	118/715
*	J	US-5,595,606 □□	01-1997	Fujikawa et al.	118/725
*	К	US-6,756,235 □□	06-2004	Liu et al.	438/3
*	L	US-20030033978□□	02-2003	Zhao et al.	118/725
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	_					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	v					
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.